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Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/790,492	ZHENG ET AL.	
Examiner	Art Unit	
Toniae M. Thomas	2822	

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Class	Subclass	Date	Examiner		
438	239-240	6/18/2005	ТМТ		
	253	6/18/2005	и		
n	255	6/18/2005	п		
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	791	6/18/2005	"		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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keyword search US-PGPUB USPAT USOCR EPO JPO Derwent IBM_TDB					
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